Notice of References Cited Application/Control No. 10/551,720 Examiner SHIN-HON CHEN Applicant(s)/Patent Under Reexamination JEON ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0124966	07-2004	Forrest, Simon J.	340/005.8
*	В	US-2003/0120925	06-2003	Rose et al.	713/176
*	С	US-7,130,454	10-2006	Berube et al.	382/118
*	D	US-2003/0236991	12-2003	Letsinger, Reed	713/200
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	F	US-			
	G	US-			
	Ι	US-			
	_	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.